

In place of PTO-1449 Form		U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Complete if Known	
APR 21 2003		INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	10/070,118
				Filing Date	08/14/2002
				Applicant(s)	Davis et al.
				Art Unit	4743 2881
				Examiner Name	Unknown
				Attorney Docket Number	26114.7
SHEET	1	OF	1		

U. S. PATENT DOCUMENTS				
Examiner's Initials	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
/	AA	4691160	09/01/1987	Ino
	AB	4851673	07/25/1989	Izumi et al.
	AC	5026988	06/25/1991	Mendenhall et al.
	AD	5463219	10/31/1995	Buckley et al.
	AE	5644220	07/01/1997	Urs et al.
	AF	5777326	07/07/1998	Rockwood et al.
	AG	5898173	04/27/1999	Franzen
	AH	6011259	01/04/2000	Whitehouse et al.
	AI	6229142	05/08/2001	Baleman et al.

FOREIGN PATENT DOCUMENTS					
Examiner's Initials	Cite No.	Foreign Patent Document (Country Code - Number - Kind)	Publication Date MM-DD-YYYY	Patentee or Applicant of Cited Document	Translation
/	AJ	GB0907511A	10/03/1962	Daly	Yes
	AK	GB1147667A	04/02/1969	Mai et al.	Yes
	AL	GB2246468A	01/29/1992	Einnigan Mat GmbH	Yes
	AM	EP0597667A	05/18/1994	Hamamatsu Photonics K. K.	Yes
	AN	WO9821742	05/22/1998	Sensar Corporation	Yes
	AO	WO9840907	09/17/1998	GBC Scientific Equipment Pty. Ltd.	Yes
	AP	WO9938190	07/29/1999	Micromass Ltd	Yes
	AQ	WO9967801	12/29/1999	Ionwerks	Yes

OTHER PRIOR ART				
Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item, date, page(s), volume, issue number(s), publisher, city/country where published		
/	AR	MJ Kristo et al., "System for Simultaneous Count/Current Measurement with a Dual-Mode Photo/Particle Detector", Review of Scientific Instruments, Vol. 59(3), pages 438-442, 1988, XP001013497		

Examiner Signature	ZIA R. HASHMI	Date Considered	10/8/04
--------------------	---------------	-----------------	---------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

